

Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	600				
$R_{DS(on)}(\Omega)$	V _{GS} = 10 V 1.2				
Q _g (Max.) (nC)	200				
Q _{gs} (nC)	24				
Q _{gd} (nC)	110				
Configuration	Single				

FEATURES

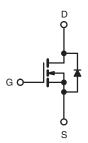
- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Isolated Central Mounting Hole
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC





D²PAK (TO-263)





N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)					
PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage	V_{DS}	600	V		
Gate-Source Voltage		V _{GS}	± 20	7 v	
Continuous Drain Current V_{GS} at 10 V $\frac{T_C}{T_{CS}}$		ı	7.0		
Continuous Drain Current	I _D	5.2	Α		
Pulsed Drain Current ^a		I _{DM}	20		
Linear Derating Factor		1.5	W/°C		
Single Pulse Avalanche Energy ^b	E _{AS}	880	mJ		
Repetitive Avalanche Currenta	I _{AR}	8.7	Α		
Repetitive Avalanche Energy ^a	E _{AR}	19	mJ		
Maximum Power Dissipation	P_{D}	190	W		
Peak Diode Recovery dV/dt ^c	dV/dt	1.5	V/ns		
Operating Junction and Storage Temperature Rang	T _J , T _{stg}	- 55 to + 150	°C		
Soldering Recommendations (Peak Temperature)		300 ^d	7		
Mounting Torque	6-32 or M3 screw		10	lbf ⋅ in	
Mounting Torque	0-32 OF IVIS SCIEW		1.1	N⋅m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. $V_{DD} = 50 \text{ V}$, starting $T_J = 25 \,^{\circ}\text{C}$, $L = 37 \,\text{mH}$, $R_g = 25 \,^{\circ}\Omega$, $I_{AS} = 6.7 \,\text{A}$ (see fig. 12). c. $I_{SD} \le 6.7 \,^{\circ}\Lambda$, $I_{AS} = 6.7 \,^{\circ}\Lambda$
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS						
PARAMETER SYMBOL TYP. MAX. UNIT						
Maximum Junction-to-Ambient	R_{thJA}	-	40			
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.24	-	°C/W		
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.65			

PARAMETER	SYMBOL	TEST	TEST CONDITIONS		TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0$	V, I _D = 250 μA	600	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference t	to 25 °C, I _D = 1 mA	-	1.2	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V$	_{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	V _G	_S = ± 20 V	-	-	± 100	nA
Zon Oak William Burin Oamal		V _{DS} = 60	V _{DS} = 600 V, V _{GS} = 0 V		-	100	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 550 V, V	/ _{GS} = 0 V, T _J = 125 °C	-	-	500	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 4.0 A ^b	-	1.2	-	Ω
Forward Transconductance	9 _{fs}	V _{DS} = 10	00 V, I _D = 4.0 A ^b	4.9	-	-	S
Dynamic						•	
Input Capacitance	C _{iss}	V	_{GS} = 0 V,	-	2900	-	
Output Capacitance	C _{oss}	V	os = 25 V,	-	270	-	рF
Reverse Transfer Capacitance	C _{rss}	f = 1.0 I	MHz, see fig. 5	-	92	-	
Total Gate Charge	Qg				-	200	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$I_D = 6.7 \text{ A}, V_{DS} = 360 \text{ V},$ see fig. 6 and 13 ^b	-	-	24	nC
Gate-Drain Charge	Q _{gd}		see lig. 6 and 13°		-	110	1
Turn-On Delay Time	t _{d(on)}		'		20	-	ns ns
Rise Time	t _r	$V_{DD} = 475 \text{ V}, \text{ I}_D = 6.7 \text{ A},$ $R_G = 6.2 \ \Omega, R_D = 67 \ \Omega, \text{ see fig. } 10^b$		-	34	-	
Turn-Off Delay Time	t _{d(off)}			-	130	-	
Fall Time	t _f			-	37	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") fro	Between lead, 6 mm (0.25") from		5.0	-	
Internal Source Inductance	L _S	package and center of die contact		-	13	-	- nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbo	MOSFET symbol showing the		-	7	A
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode		-	-	1 8	A
Body Diode Voltage	V_{SD}	T _J = 25 °C, I _S = 6.7 A, V _{GS} = 0 V ^b		-	-	1.8	V
Body Diode Reverse Recovery Time	t _{rr}	T - 25 °C 1	6 7 A dI/dt = 100 A/v-b	-	610	920	ns
Body Diode Reverse Recovery Charge	Q _{rr}	$T_J = 25 ^{\circ}\text{C}, I_F = 6.7 \text{A}, \text{dI/dt} = 100 \text{A/} \mu \text{s}^{\text{b}}$		-	3.2	4.8	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by			y L _S and	L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 300 µs; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

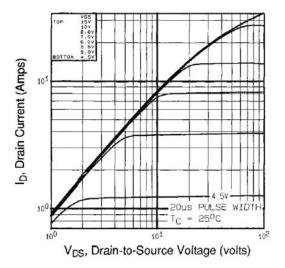


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

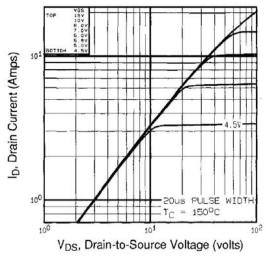


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

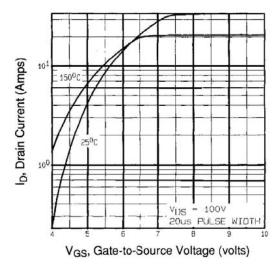


Fig. 3 - Typical Transfer Characteristics

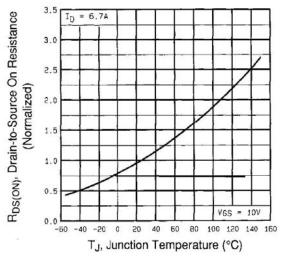


Fig. 4 - Normalized On-Resistance vs. Temperature



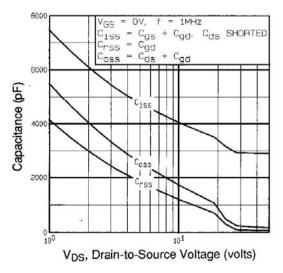


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

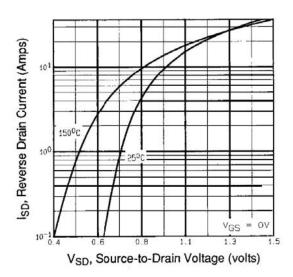


Fig. 7 - Typical Source-Drain Diode Forward Voltage

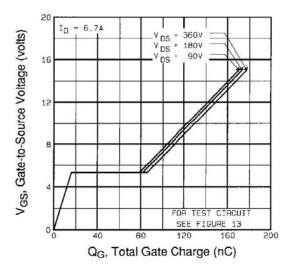


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

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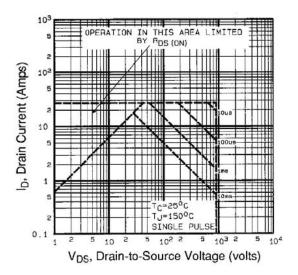


Fig. 8 - Maximum Safe Operating Area



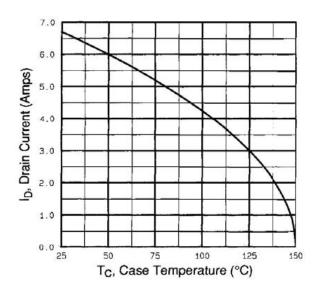


Fig. 9 - Maximum Drain Current vs. Case Temperature

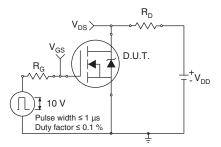


Fig. 10a - Switching Time Test Circuit

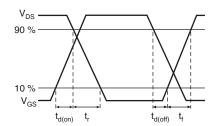


Fig. 10b - Switching Time Waveforms

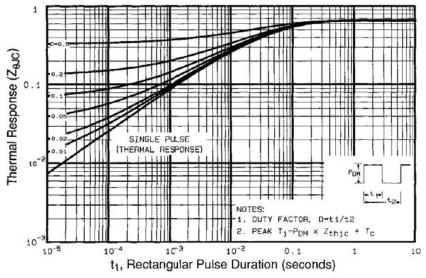


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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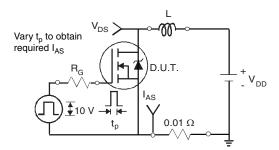


Fig. 12a - Unclamped Inductive Test Circuit

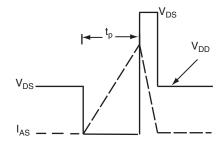


Fig. 12b - Unclamped Inductive Waveforms

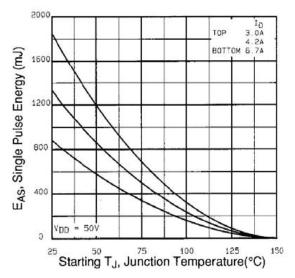


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

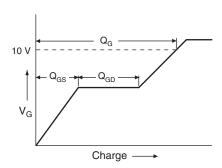


Fig. 13a - Basic Gate Charge Waveform

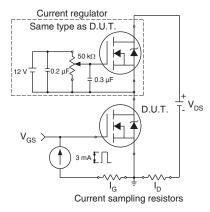
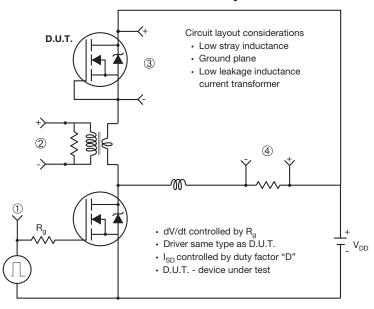


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



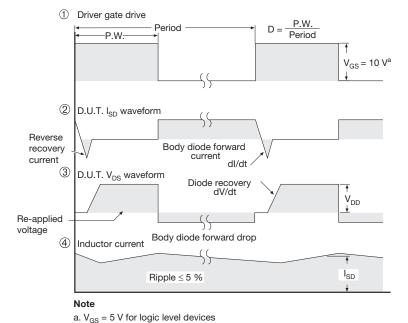
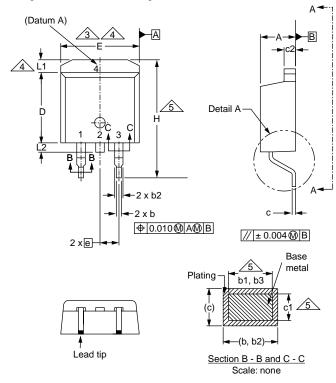


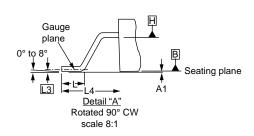
Fig. 14 - For N-Channel

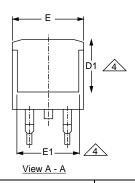
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TO-263AB (HIGH VOLTAGE)







	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
Α	4.06	4.83	0.160	0.190
A1	0.00	0.25	0.000	0.010
b	0.51	0.99	0.020	0.039
b1	0.51	0.89	0.020	0.035
b2	1.14	1.78	0.045	0.070
b3	1.14	1.73	0.045	0.068
С	0.38	0.74	0.015	0.029
c1	0.38	0.58	0.015	0.023
c2	1.14	1.65	0.045	0.065
D	8.38	9.65	0.330	0.380

	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
D1	6.86	-	0.270	-
Е	9.65	10.67	0.380	0.420
E1	6.22	-	0.245	-
е	2.54 BSC		0.100 BSC	
Η	14.61	15.88	0.575	0.625
L	1.78	2.79	0.070	0.110
L1	-	1.65	-	0.066
L2	-	1.78	-	0.070
L3	0.25 BSC		0.010	BSC
L4	4.78	5.28	0.188	0.208

ECN: S-82110-Rev. A, 15-Sep-08

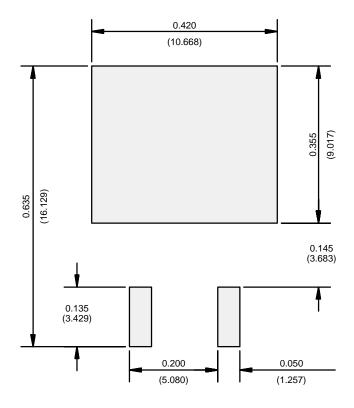
DWG: 5970

Notes

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Dimensions are shown in millimeters (inches).
- 3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outmost extremes of the plastic body at datum A.
- 4. Thermal PAD contour optional within dimension E, L1, D1 and E1.
- 5. Dimension b1 and c1 apply to base metal only.
- 6. Datum A and B to be determined at datum plane H.
- 7. Outline conforms to JEDEC outline to TO-263AB.



RECOMMENDED MINIMUM PADS FOR D²PAK: 3-Lead



Recommended Minimum Pads Dimensions in Inches/(mm)



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